

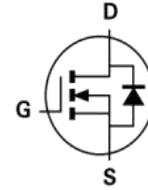


LT40N03AG

N-Channel Enhancement Mode MOSFET

MAIN CHARACTERISTICS

I_D	40A
V_{DSS}	30V
$R_{DS(on)}$ -typ (@ $V_{GS}=10V$)	7.6m Ω



PDFN5x6

FEATURES

- Adopt advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

APPLICATIONS

- Battery protection
- Load switch
- Uninterruptible power supply

MECHANICAL DATA

- Case: Molded plastic
- Mounting Position: Any
- Molded Plastic: UL Flammability Classification Rating 94V-0
- Lead free in compliance with EU RoHS 2011/65/EU directive
- Solder bath temperature 275°C maximum, 10s per JESD 22-B106

Product specification classification

Part Number	Package	Mode Name	Pack
LT40N03AG	PDFN5x6	LT40N03AG	Tape



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Maximum Ratings at Tc=25°C unless otherwise specified

Characteristics	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	30	V
Gate-Source Voltage	V_{GS}	±20	V
Continue Drain Current	I_D	40	A
Pulsed Drain Current (Note1)	I_{DM}	160	A
Power Dissipation	P_D	35	W
Operating Temperature Range	T_J	150	°C
Storage Temperature Range	T_{STG}	-55 to +150	°C
Thermal Resistance, Junction to Case	$R_{\theta JC}$	3.6	°C/W
Thermal Resistance, Junction to Ambient	$R_{\theta JA}$	62	°C/W

Note1:Pulse test: 300 μs pulse width, 2 % duty cycle

Electrical Characteristics at Tc=25°C unless otherwise specified

Characteristics	Test Condition	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_D = 250 \mu A$	BV_{DSS}	30	-	-	V
Drain-Source Leakage Current	$V_{DS} = 30 V, V_{GS} = 0 V$	I_{DSS}	-	-	1	μA
Gate Leakage Current	$V_{GS} = \pm 20 V, V_{DS} = 0 V$	I_{GSS}	-	-	±100	nA
Gate-Source Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	$V_{GS(th)}$	1	-	2.5	V
Drain-Source On-State Resistance (Note 3)	$V_{GS} = 10 V, I_D = 20 A$	$R_{DS(on)}$	-	7.6	10	mΩ
	$V_{GS} = 4.5 V, I_D = 10 A$	$R_{DS(on)}$	-	11	19	mΩ
Forward Transconductance	$V_{DS} = 5 V, I_D = 20 A$	g_{FS}	26	-	-	S
Input Capacitance	$V_{GS} = 0 V, V_{DS} = 15 V, f = 1.0 MHz$	C_{iss}	-	1000	-	pF
Output Capacitance		C_{oss}	-	180.8	-	pF
Reverse Transfer Capacitance		C_{rss}	-	164.4	-	pF
Turn-on Delay Time(Note2)	$V_{DS} = 15 V, R_L = 0.75 \Omega, V_{GS} = 10 V, R_G = 3 \Omega$ (Note3,4)	$t_{d(ON)}$	-	5	-	ns
Rise Time(Note2)		t_r	-	12	-	ns
Turn-Off Delay Time(Note2)		$t_{d(OFF)}$	-	19	-	ns
Fall Time(Note2)		t_f	-	6	-	ns
Total Gate Charge(Note2)	$V_{DS} = 15 V, I_D = 20 A, V_{GS} = 10 V$ (Note3,4)	Q_G	-	17	-	nC
Gate to Source Charge(Note2)		Q_{GS}	-	2.8	-	nC
Gate to Drain Charge(Note2)		Q_{GD}	-	3.9	-	nC

Source-Drain Diode Characteristics at Ta=25°C unless otherwise specified

Characteristics	Test Condition	Symbo	Min.	Typ.	Max.	Unit
Maximun Body-Diode Continuous Current		I_S	-	-	40	A
Drain-Source Diode Forward Voltage	$V_{GS} = 0 V, I_S = 20 A, T_J = 25^\circ C$	V_{SD}	-	-	1.2	V
Reverse Recovery Time(Note2)	$I_S = I_F, I_{SD} = 20 A, V_{GS} = 0 V, di/dt = 100 A/\mu s$ (Note3)	t_{rr}	-	19	-	ns
Reverse Recovery Charge(Note2)		Q_{rr}	-	10	-	nC

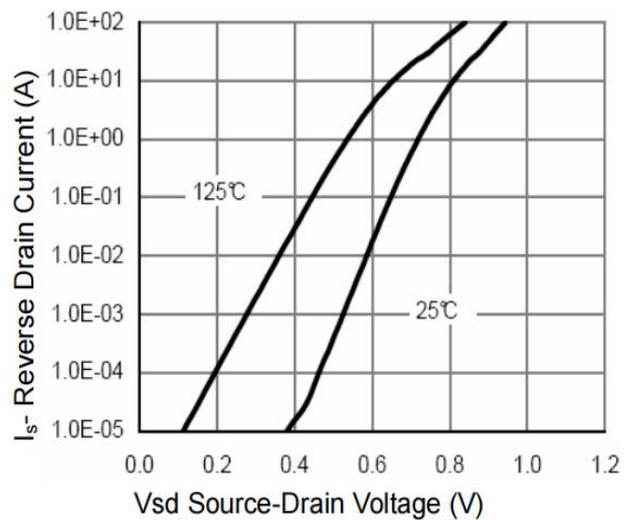
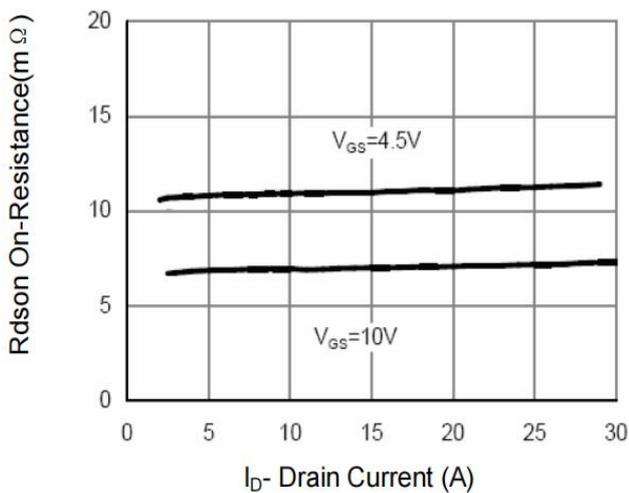
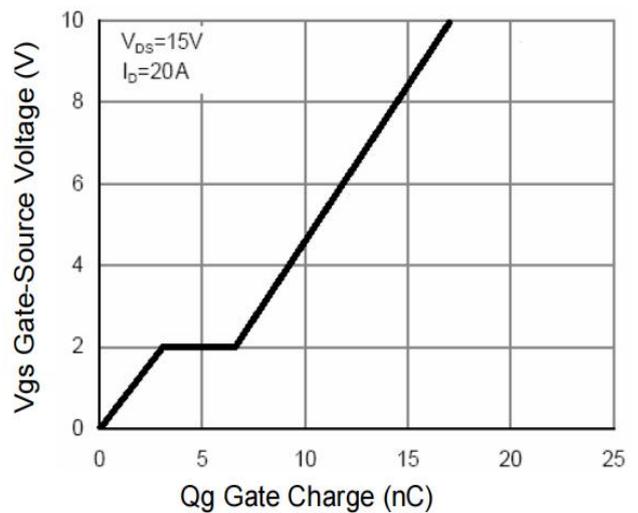
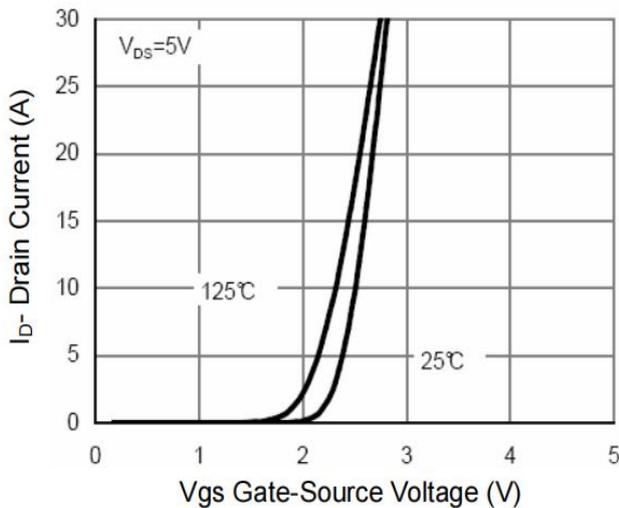
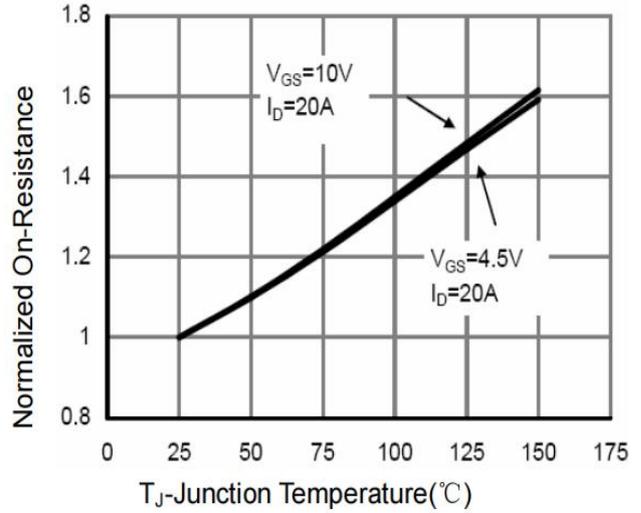
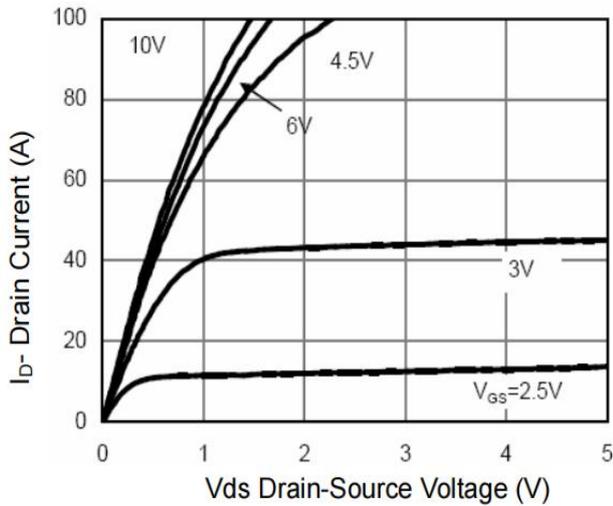
Note2:Pulse test: 300 μs pulse width, 2 % duty cycle



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RATINGS AND CHARACTERISTIC CURVES

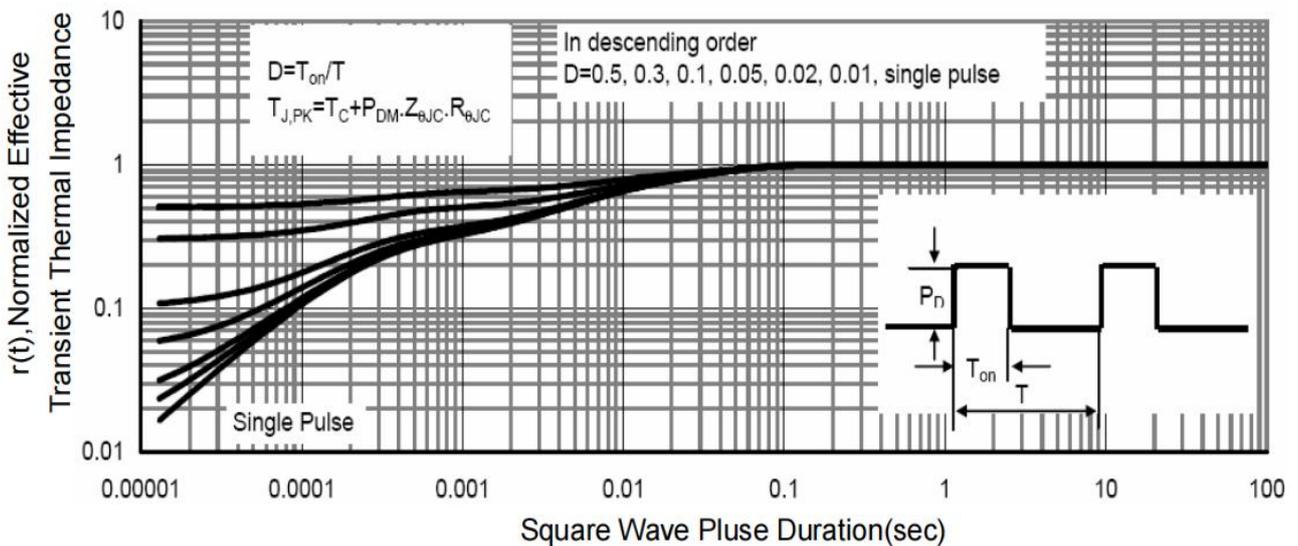
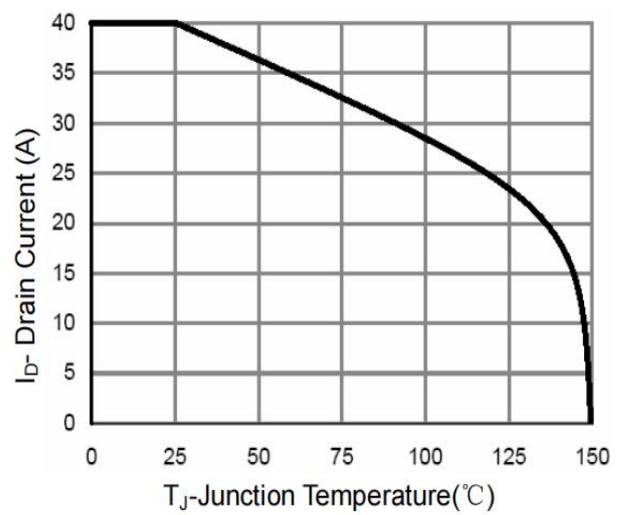
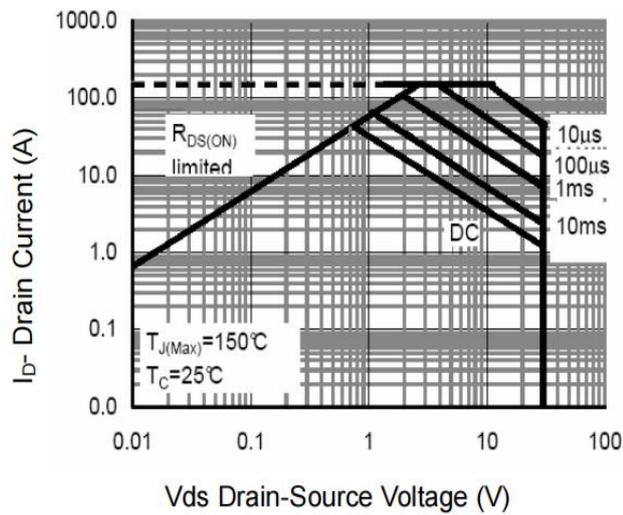
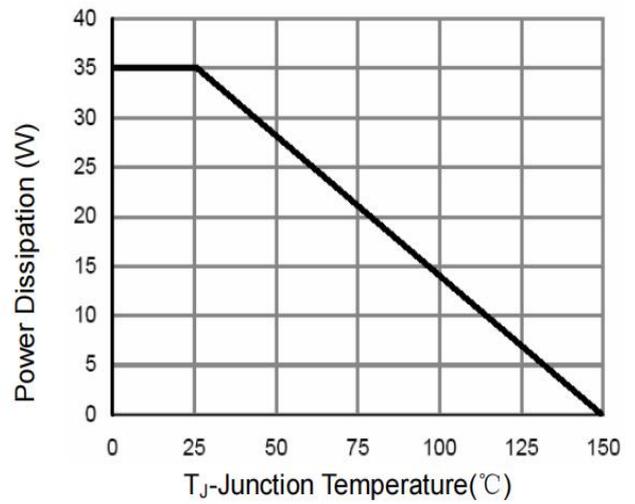
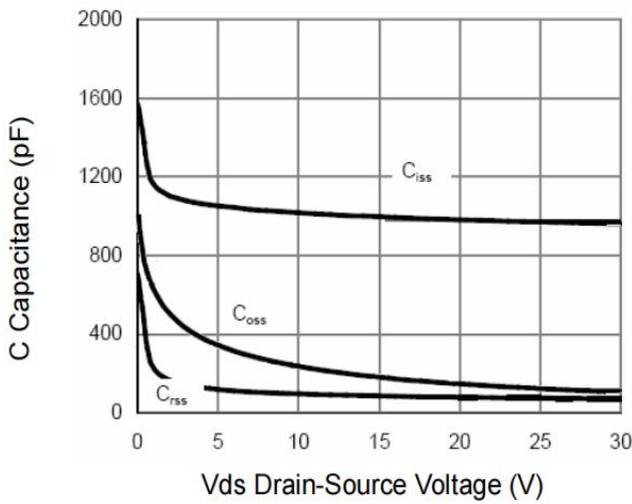




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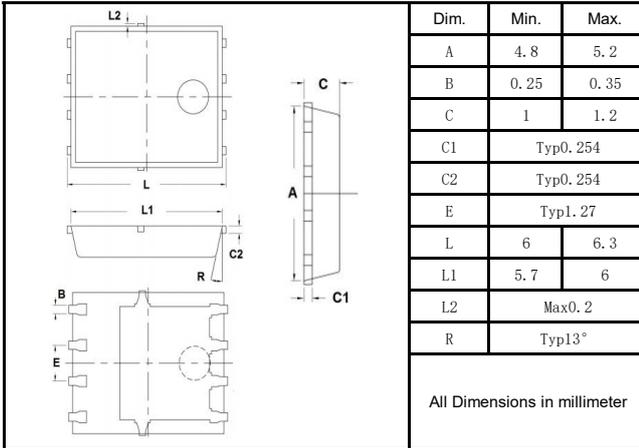


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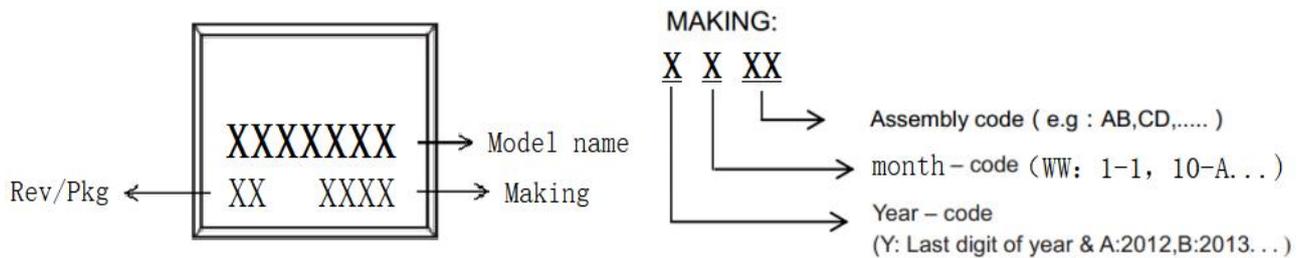
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Package Outline Dimensions millimeters

PDFN5*6



Marking on the body



packing instruction

PKG	最小包装	内盒	外箱
PDFN5x6			
	5000pcs/盘	10000pcs/盒	50000pcs/箱

Notice

All product, product specifications and data are subject to change without notice to improve. The right to explain is owned by LINGXUN electronics

company.

Confirm that operation temperature is within the specified range described in the product specification. Avoid applying power exceeding normal rated

power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.

LINGXUN electronics shall not be in any way responsible or liable for failure induced under deviant condition from what is defined in this document.